Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | LEE, HO-YOUNG | Examiner | Art Unit | Long Nguyen | 2816 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,774,695	08-2004	Hayashi et al.	327/333
	В	US-2002/0050849 A1	05-2002	Hayashi et al.	327/333
	O	US-6,043,699	03-2000	Shimizu, Yasuhide	327/333
	D	US-			
	E	US-			
	F	US-			
	G	US-	1		
	Н	US-			
	ı	US-			
	J	US-			
	κ	US-			-
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	σ					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	υ							
	V							
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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